

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination ISHII ET AL.	
		Examiner Patrick A. Darno	Art Unit 2163	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0254934 A1	12-2004	Ho et al.	707/009
*	B	US-2005/0091658 A1	04-2005	Kavalam et al.	718/104
*	C	US-5,260,551	11-1993	Wiik et al.	340/5.28
*	D	US-2004/0203589 A1	10-2004	Wang et al.	455/410
*	E	US-2004/0153552 A1	08-2004	Trossen et al.	709/229
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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